

**Notice of References Cited**

Application/Control No.

10/575,201

Applicant(s)/Patent Under  
Reexamination  
HAHN ET AL.

Examiner

Joseph D. Anthony

Art Unit

1796

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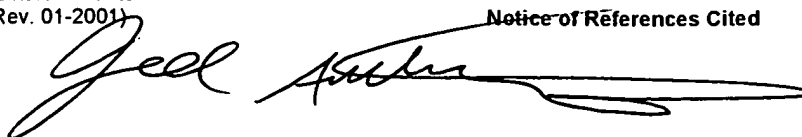
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